

## **MOSFET**

Metal Oxide Semiconductor Field Effect Transistor

CoolMOS™ C7

600V CoolMOS™ C7 Power Transistor IPP60R040C7

## **Data Sheet**

Rev. 2.0 Final



#### IPP60R040C7

## 1 Description

CoolMOS™ C7 is a revolutionary technology for high voltage power MOSFETs, designed according to the superjunction (SJ) principle and pioneered by Infineon Technologies.

600V CoolMOS™ C7 series combines the experience of the leading SJ MOSFET supplier with high class innovation.

The 600V C7 is the first technology ever with R<sub>DS(on)</sub>\*A below 10hm\*mm².

#### **Features**

- Suitable for hard and soft switching (PFC and high performance LLC)
- Increased MOSFET dv/dt ruggedness to 120V/ns
- Increased efficiency due to best in class FOM R<sub>DS(on)</sub>\*E<sub>oss</sub> and R<sub>DS(on)</sub>\*Q<sub>g</sub>
- Best in class R<sub>DS(on)</sub> /package
- Qualified for industrial grade applications according to JEDEC (J-STD20 and JESD22)

#### **Benefits**

- Increased economies of scale by use in PFC and PWM topologies in the application
- Higher dv/dt limit enables faster switching leading to higher efficiency
- Enabling higher system efficiency by lower switching losses
- Increased power density solutions due to smaller packages
- Suitable for applications such as server, telecom and solar
- Higher switching frequencies possible without loss in efficiency due to low Eoss and Qg

### **Applications**

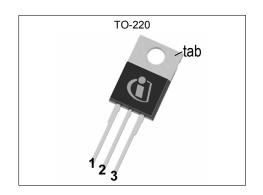
PFC stages and PWM stages (TTF, LLC) for high power/performance SMPS e.g. Computing, Server, Telecom, UPS and Solar.

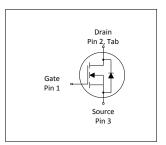
Please note: For MOSFET paralleling the use of ferrite beads on the gate or separate totem poles is generally recommended.



Table : Itay : officialists : aranicists							
Value	Unit						
650	V						
40	mΩ						
107	nC						
211	A						
73	A						
12.6	μJ						
450	A/µs						
	650 40 107 211 73 12.6						

Type / Ordering Code	Package	Marking	Related Links
IPP60R040C7	PG-TO 220	60C7040	see Appendix A

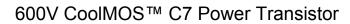














## IPP60R040C7

## **Table of Contents**

Description
Maximum ratings
Thermal characteristics
Electrical characteristics
Electrical characteristics diagrams
est Circuits
Package Outlines
Appendix A
Revision History
Disclaimer



# **2** Maximum ratings at $T_j = 25$ °C, unless otherwise specified

Table 2 **Maximum ratings** 

Parameter	0 1	Values				
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Continuous drain current <sup>1)</sup>	I <sub>D</sub>	-	-	50 32	А	T <sub>C</sub> =25°C T <sub>C</sub> =100°C
Pulsed drain current <sup>2)</sup>	I <sub>D,pulse</sub>	-	-	211	Α	T <sub>C</sub> =25°C
Avalanche energy, single pulse	<b>E</b> AS	-	-	249	mJ	I <sub>D</sub> =7.4A; V <sub>DD</sub> =50V; see table 10
Avalanche energy, repetitive	<b>E</b> AR	-	-	1.24	mJ	I <sub>D</sub> =7.4A; V <sub>DD</sub> =50V; see table 10
Avalanche current, single pulse	I <sub>AS</sub>	-	-	7.4	Α	-
MOSFET dv/dt ruggedness	dv/dt	-	-	120	V/ns	V <sub>DS</sub> =0400V
Gate source voltage (static)	V <sub>GS</sub>	-20	-	20	V	static;
Gate source voltage (dynamic)	V <sub>GS</sub>	-30	-	30	V	AC (f>1 Hz)
Power dissipation	P <sub>tot</sub>	-	-	227	W	<i>T</i> <sub>C</sub> =25°C
Storage temperature	$T_{ m stg}$	-55	-	150	°C	-
Operating junction temperature	T <sub>j</sub>	-55	-	150	°C	-
Mounting torque	-	-	-	60	Ncm	M3 and M3.5 screws
Continuous diode forward current	I <sub>S</sub>	-	-	50	Α	<i>T</i> <sub>C</sub> =25°C
Diode pulse current <sup>2)</sup>	I <sub>S,pulse</sub>	-	-	211	Α	<i>T</i> <sub>C</sub> =25°C
Reverse diode dv/dt <sup>3)</sup>	dv/dt	-	-	20	V/ns	$V_{DS}$ =0400V, $I_{SD}$ <=11.4A, $T_j$ =25°C see table 8
Maximum diode commutation speed	di <sub>f</sub> /dt	-	-	450	A/μs	V <sub>DS</sub> =0400V, I <sub>SD</sub> <=11.4A, T <sub>j</sub> =25°C see table 8
Insulation withstand voltage	V <sub>ISO</sub>	-	-	n.a.	V	V <sub>rms</sub> , T <sub>C</sub> =25°C, t=1min

 $<sup>^{1)}</sup>$  Limited by  $T_{j\,\text{max}}.$   $^{2)}$  Pulse width  $t_p$  limited by  $T_{j,\text{max}}$   $^{3)}$  Identical low side and high side switch



## 3 Thermal characteristics

## **Table 3** Thermal characteristics

Parameter	Complete	Values			1111111	Nata / Tank Candikian
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Thermal resistance, junction - case	R <sub>thJC</sub>	-	-	0.55	°C/W	-
Thermal resistance, junction - ambient	R <sub>thJA</sub>	-	-	62	°C/W	leaded
Thermal resistance, junction - ambient for SMD version	$R_{thJA}$	-	-	-	°C/W	n.a.
Soldering temperature, wavesoldering only allowed at leads	T <sub>sold</sub>	-	-	260	°C	1.6mm (0.063 in.) from case for 10s



# **4 Electrical characteristics** at $T_j$ =25°C, unless otherwise specified

Table 4 **Static characteristics** 

Parameter	0		Values			
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	600	-	-	V	$V_{GS}$ =0V, $I_D$ =1mA
Gate threshold voltage	$V_{(GS)th}$	3	3.5	4	V	$V_{\rm DS}=V_{\rm GS},\ I_{\rm D}=1.24{\rm mA}$
Zero gate voltage drain current	I <sub>DSS</sub>	-	- 10	1 -	μΑ	V <sub>DS</sub> =600, V <sub>GS</sub> =0V, T <sub>i</sub> =25°C V <sub>DS</sub> =600, V <sub>GS</sub> =0V, T <sub>j</sub> =150°C
Gate-source leakage current	I <sub>GSS</sub>	-	-	100	nA	V <sub>GS</sub> =20V, V <sub>DS</sub> =0V
Drain-source on-state resistance	R <sub>DS(on)</sub>	-	0.034 0.077	0.040	Ω	V <sub>GS</sub> =10V, I <sub>D</sub> =24.9A, T <sub>j</sub> =25°C V <sub>GS</sub> =10V, I <sub>D</sub> =24.9A, T <sub>j</sub> =150°C
Gate resistance	R <sub>G</sub>	-	0.77	-	Ω	f=1MHz, open drain

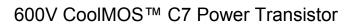
Table 5 **Dynamic characteristics** 

Parameter	Or smalle and	Values			11!4	Note / Took Open difficu
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Input capacitance	Ciss	-	4340	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =400V, f=250kHz
Output capacitance	Coss	-	85	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =400V, f=250kHz
Effective output capacitance, energy related <sup>1)</sup>	C <sub>o(er)</sub>	-	158	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =0400V
Effective output capacitance, time related <sup>2)</sup>	C <sub>o(tr)</sub>	-	1640	-	pF	$I_D$ =constant, $V_{GS}$ =0V, $V_{DS}$ =0400V
Turn-on delay time	t <sub>d(on)</sub>	-	18.5	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =24.9A, $R_{\rm G}$ =3.3 $\Omega$ ; see table 9
Rise time	t <sub>r</sub>	-	11	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =24.9A, $R_{\rm G}$ =3.3 $\Omega$ ; see table 9
Turn-off delay time	$t_{ m d(off)}$	-	81	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =24.9A, $R_{\rm G}$ =3.3 $\Omega$ ; see table 9
Fall time	t <sub>f</sub>	-	3.2	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =24.9A, $R_{\rm G}$ =3.3 $\Omega$ ; see table 9

Table 6 Gate charge characteristics

Parameter	Cymbal	Values			I I m i4	Nata / Tast Candition
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Gate to source charge	Q <sub>gs</sub>	-	22	-	nC	$V_{DD}$ =400V, $I_{D}$ =24.9A, $V_{GS}$ =0 to 10V
Gate to drain charge	$Q_{ m gd}$	-	36	-	nC	$V_{DD}$ =400V, $I_{D}$ =24.9A, $V_{GS}$ =0 to 10V
Gate charge total	<b>Q</b> g	-	107	-	nC	$V_{DD}$ =400V, $I_{D}$ =24.9A, $V_{GS}$ =0 to 10V
Gate plateau voltage	V <sub>plateau</sub>	-	5.0	-	V	$V_{DD}$ =400V, $I_{D}$ =24.9A, $V_{GS}$ =0 to 10V

 $<sup>^{1)}</sup>$   $C_{\text{o(er)}}$  is a fixed capacitance that gives the same stored energy as  $C_{\text{oss}}$  while  $V_{\text{DS}}$  is rising from 0 to 400V  $^{2)}$   $C_{\text{o(tr)}}$  is a fixed capacitance that gives the same charging time as  $C_{\text{oss}}$  while  $V_{\text{DS}}$  is rising from 0 to 400V





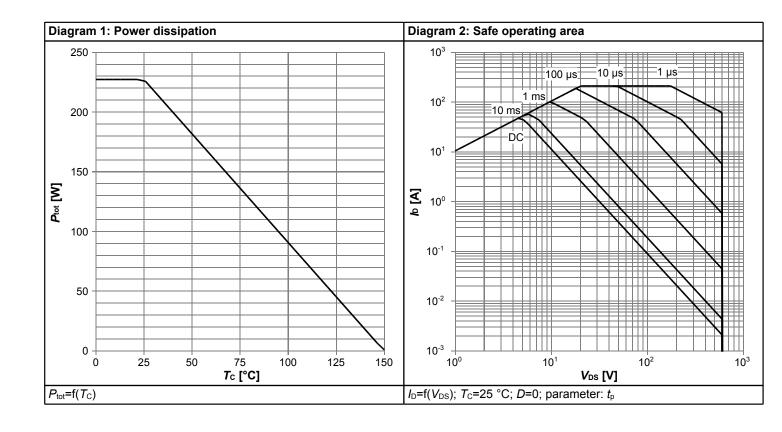
## IPP60R040C7

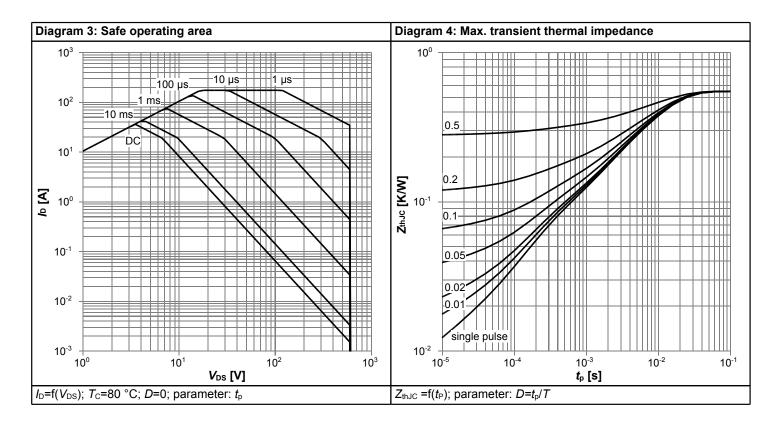
## Table 7 Reverse diode characteristics

Parameter	Symbol	Values			Unit	Note / Took Condition
		Min.	Тур.	Max.	Ullit	Note / Test Condition
Diode forward voltage	V <sub>SD</sub>	-	0.9	-	V	V <sub>GS</sub> =0V, I <sub>F</sub> =24.9A, T <sub>j</sub> =25°C
Reverse recovery time	t <sub>rr</sub>	-	460	-	ns	$V_R$ =400V, $I_F$ =24.9A, $di_F/dt$ =100A/ $\mu$ s; see table 8
Reverse recovery charge	Q <sub>rr</sub>	-	9.2	-	μC	$V_R$ =400V, $I_F$ =24.9A, $di_F/dt$ =100A/ $\mu$ s; see table 8
Peak reverse recovery current	I <sub>rrm</sub>	-	40	-	А	$V_R$ =400V, $I_F$ =24.9A, $di_F/dt$ =100A/ $\mu$ s; see table 8

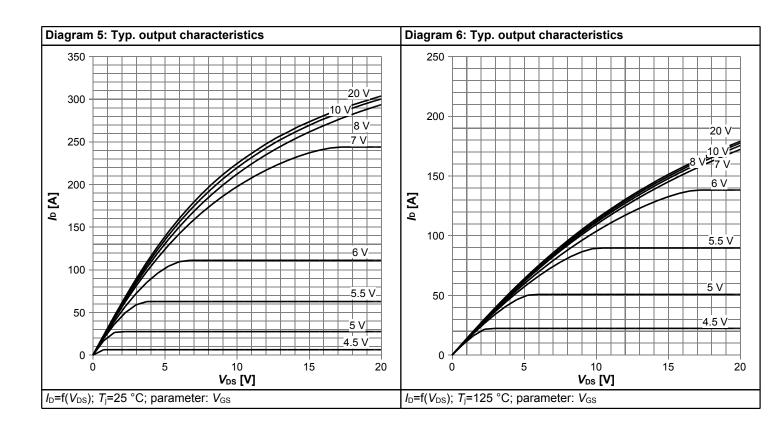


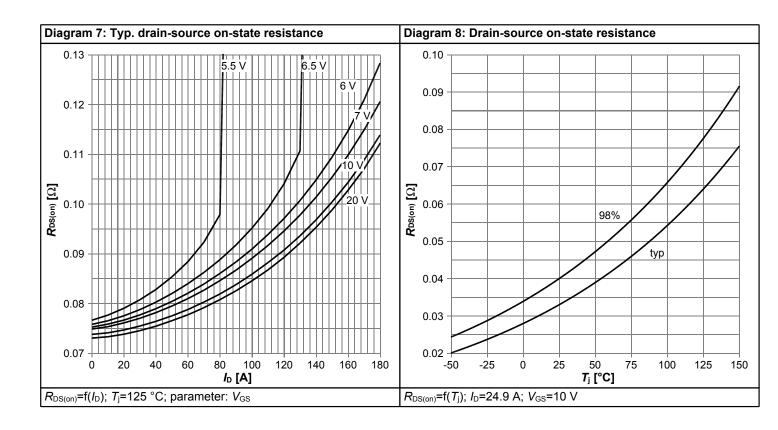
## 5 Electrical characteristics diagrams



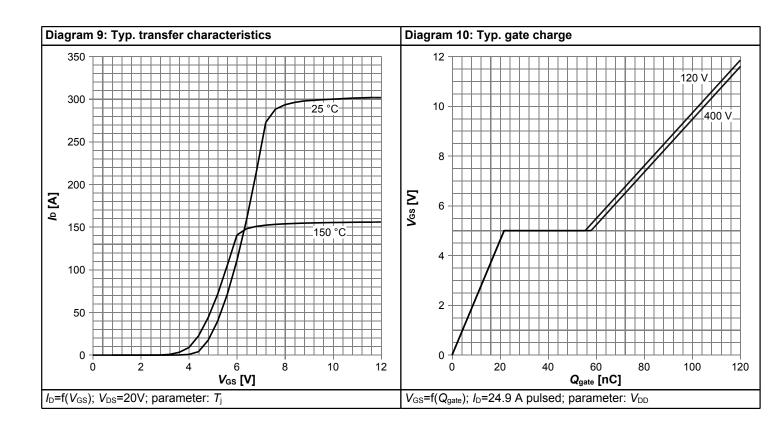


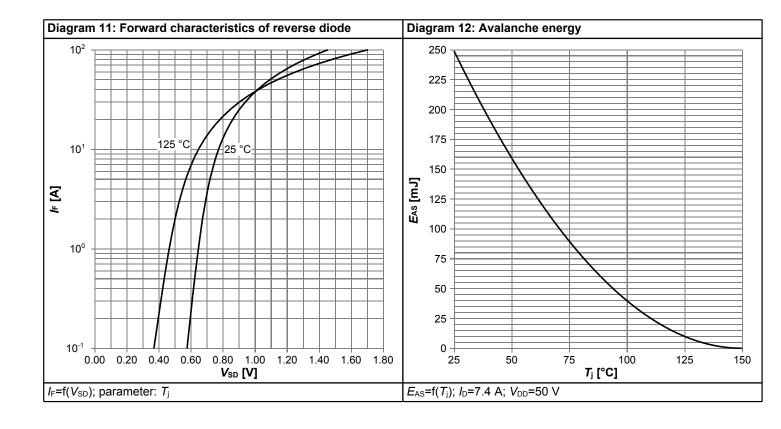




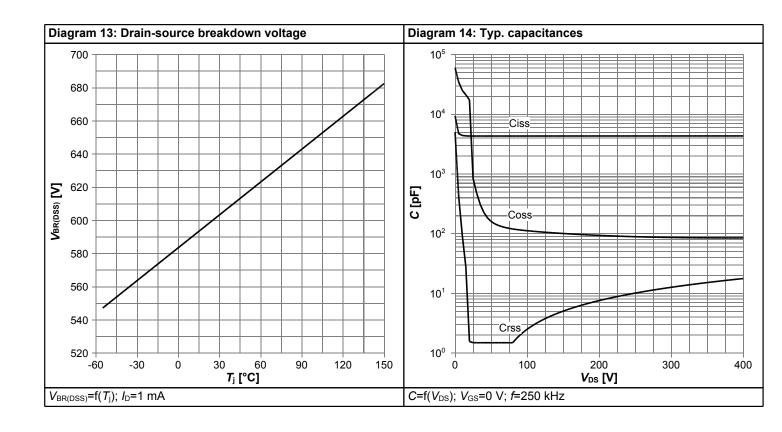


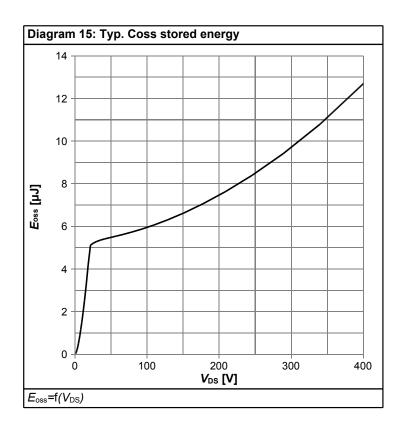














## 6 Test Circuits

Table 8 Diode characteristics

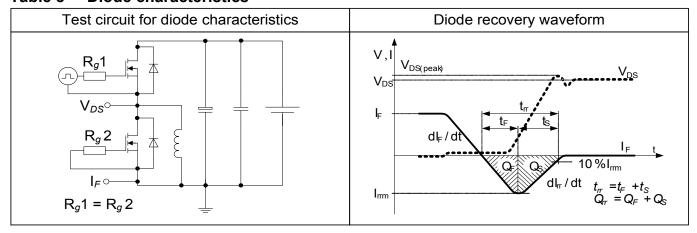


Table 9 Switching times

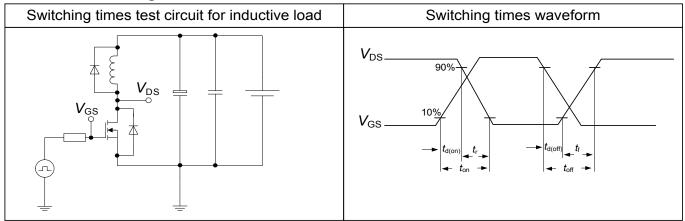
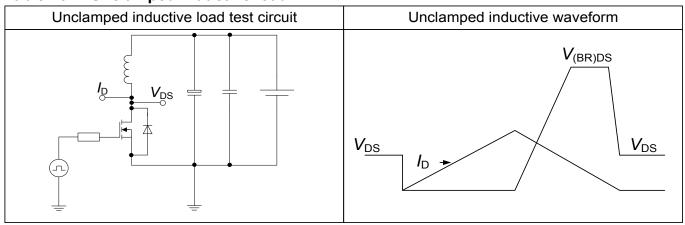


Table 10 Unclamped inductive load





## 7 Package Outlines

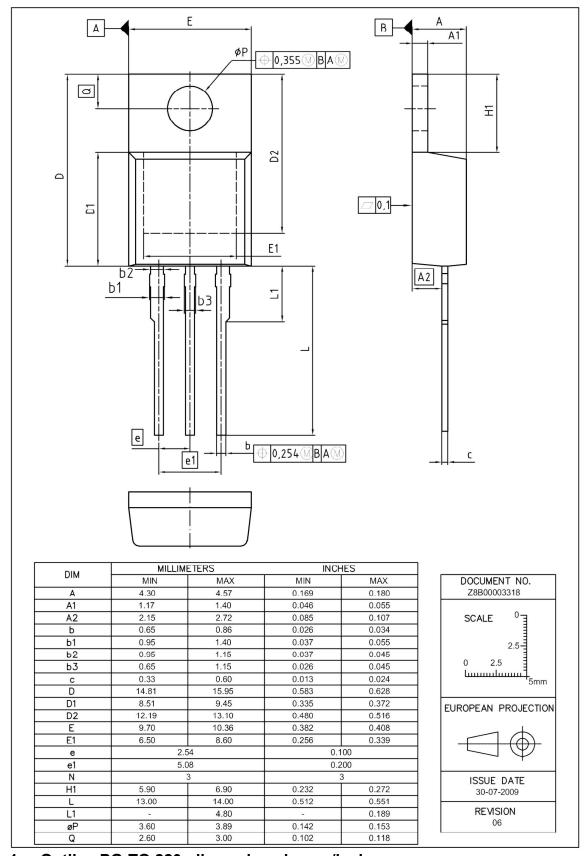


Figure 1 Outline PG-TO 220, dimensions in mm/inches



## 8 Appendix A

## Table 11 Related Links

- IFX CoolMOS<sup>™</sup> C7 Webpage: <u>www.infineon.com</u>
- IFX CoolMOS<sup>™</sup> C7 application note: <u>www.infineon.com</u>
- IFX CoolMOS<sup>™</sup> C7 simulation model: www.infineon.com
- IFX Design tools: www.infineon.com



#### 600V CoolMOS™ C7 Power Transistor

IPP60R040C7

#### **Revision History**

IPP60R040C7

Revision: 2015-05-08, Rev. 2.0

Previous Revision

i Tevious Nevision						
Revision	Date	Subjects (major changes since last revision)				
2.0	2015-05-08	Release of final version				

#### We Listen to Your Comments

Any information within this document that you feel is wrong, unclear or missing at all? Your feedback will help us to continuously improve the quality of this document. Please send your proposal (including a reference to this document) to: erratum@infineon.com

Published by Infineon Technologies AG 81726 München, Germany © 2015 Infineon Technologies AG All Rights Reserved.

#### Legal Disclaimer

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics. With respect to any examples or hints given herein, any typical values stated herein and/or any information regarding the application of the device, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation, warranties of non-infringement of intellectual property rights of any third party.

#### Information

For further information on technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies Office (www.infineon.com).

## Warnings

Due to technical requirements, components may contain dangerous substances. For information on the types in question, please contact the nearest Infineon Technologies Office.

The Infineon Technologies component described in this Data Sheet may be used in life-support devices or systems and/or automotive, aviation and aerospace applications or systems only with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support, automotive, aviation and aerospace device or system or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.